TOSHIBA MULTI CHIP DISCRETE DEVICE

HN2E04F

Super High Speed Switching Application Audio Frequency Amplifier Application Audio Low Noise Amplifier Application

Q1

High Voltage $:V_{CEO} = -120V$ High DC Current Gain $:h_{FE} = 200 \sim 700$

Good h_{FE Linearity} : $h_{FE}(I_C = -0.1 \text{mA})/h_{FE}(I_C = -2 \text{mA}) = 0.95$

Q2

Q1 (Transistor) : 2SA1587 equivalent Q2 (Diode) : 1SS352 equivalent

Q1 (Transistor) Absolute Maximum Ratings (Ta = 25°C)

| Characteristic | Symbol | Rating | Unit |
|---------------------------|------------------|--------|------|
| Collector-base voltage | V _{CBO} | -120 | V |
| Collector-emitter voltage | V _{CEO} | -120 | V |
| Emitter-base voltage | V _{EBO} | -5 | V |
| Collector current | IC | -100 | mA |
| Base current | Ι _Β | -20 | mA |

Unit: mm 2.8 - 0.3 1.00 1.00 1.00 2.Emitter 3. Cathode 4. Anode 5. Collector SM6 6. Base JEDEC JEITA TOSHIBA 2.8 - 0.3 1.00 1.0

Weight:0.015g (typ.)

Q2 (Diode) Absolute Maximum Ratings (Ta = 25°C)

| Characteristic | Symbol | Rating | Unit |
|--------------------------------|------------------|--------|------|
| Maximum (peak) reverse voltage | V_{RM} | 85 | V |
| Reverse voltage | V _R | 80 | V |
| Maximum (peak) forward current | I _{FM} | 300 | mA |
| Average forward current | IO | 100 | mA |
| Surge current (10ms) | I _{FSM} | 1 | Α |

Absolute Maximum Ratings (Ta = 25°C) (Q1, Q2 Common)

| Characteristic | Symbol | Rating | Unit |
|-----------------------------|------------------|----------------|------|
| Collector power dissipation | P _C * | 300 | mW |
| Junction temperature | Tj | 125 | °C |
| Storage temperature range | T _{stg} | –55∼125 | °C |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

^{*}Total rating: Power dissipation per element should not exceed 200mW per element.

Q1 (Transistor) Electrical Characteristics (Ta = 25°C)

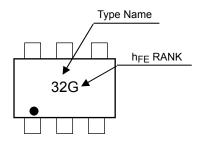
| Characteristic | Symbol | Test Circuit | Test Condition | Min | Тур. | Max | Unit |
|--------------------------------------|----------------------|-----------------|--|-----|------|------|------|
| Collector cut-off current | I _{CBO} | _ | $V_{CB} = -120V$, $I_E = 0$ | _ | _ | -100 | nA |
| Emitter cut-off current | I _{EBO} | _ | $V_{EB} = -5V$, $I_{C} = 0$ | _ | _ | -100 | nA |
| DC current gain | h _{FE} * | _ | $V_{CE} = -6V, I_{C} = -2mA$ | 200 | _ | 700 | |
| Collector-emitter saturation voltage | V _{CE(sat)} | _ | I _C =-10mA, I _B =-1mA | _ | _ | -0.3 | V |
| Transition Frequency | f _T | _ | $V_{CE} = -6V$, $I_{C} = -1mA$ | _ | 100 | _ | MHz |
| Collector Output Capacitance | C _{ob} | _ | V _{CB} =–10V, I _E = 0,f=1MHz | _ | 4 | _ | pF |
| Noise figure | NF | _ | $V_{CE} = -6 \text{ V}, I_{C} = -0.1 \text{ mA}$ $f = 1 \text{ kHz}, R_g = 10 \text{ k}\Omega$ | _ | 1.0 | _ | dB |

^{*:} h_{FE} Classifications $GR(G):200\sim400$, $BL(L):350\sim700$ ()Marking Symbol

Q2 (Diode) Electrical Characteristics (Ta = 25°C)

| Characteristic | Symbol | Test Circuit | Test Condition | Min | Тур. | Max | Unit |
|-----------------------|--------------------|-----------------|-------------------------------|-----|------|------|------|
| Forward voltage | V _{F (1)} | _ | I _F = 1mA | _ | 0.62 | _ | |
| | V _{F (2)} | _ | I _F = 10mA | _ | 0.75 | 1 | V |
| | V _{F (3)} | _ | I _F = 100mA | _ | 0.98 | 1.20 | 1 |
| Reverse current - | I _{R (1)} | _ | V _R = 30V | _ | _ | 0.1 | μA |
| | I _{R (2)} | _ | V _R = 80V | _ | - | 0.5 | |
| Total capacitance | C _T | _ | V _R = 0, f = 1MHz | _ | 0.5 | _ | pF |
| Reverse recovery time | t _{rr} | _ | I _F = 10mA (fig.1) | _ | 1.6 | _ | ns |

Marking



Equivalent Circuit (Top View)

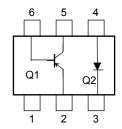
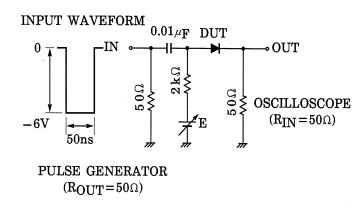
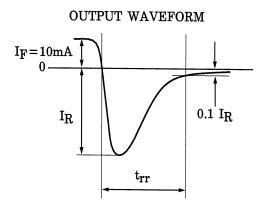


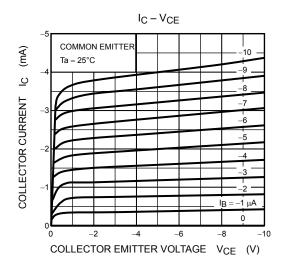
Fig. 1: Reverse Recovery Time (t_{rr}) Test Circuit

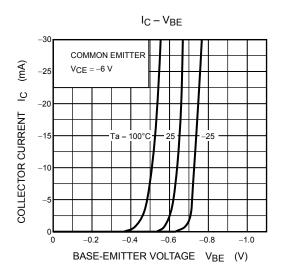


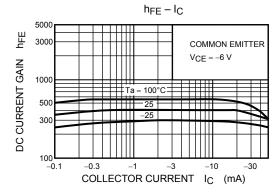


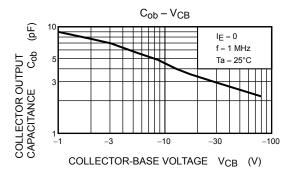
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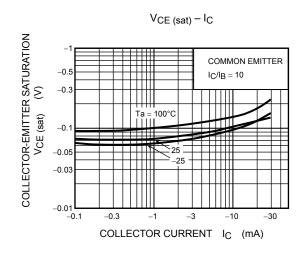
Q1

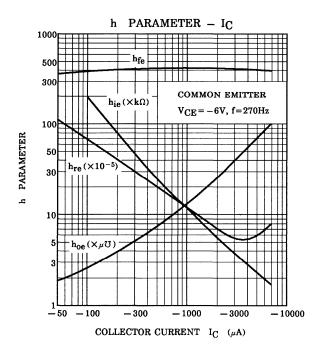


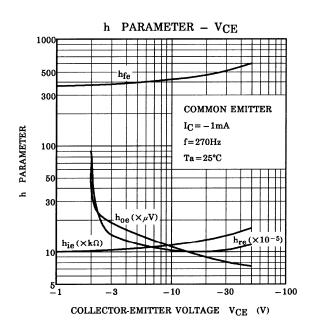


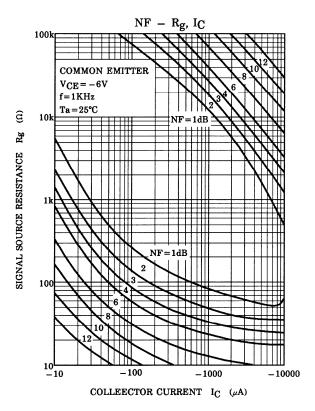


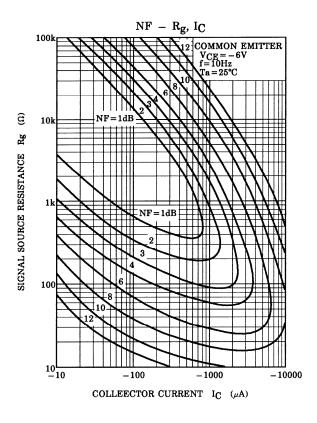




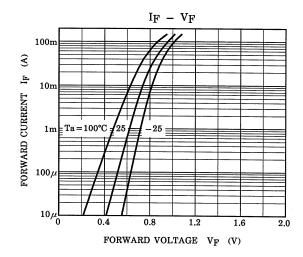


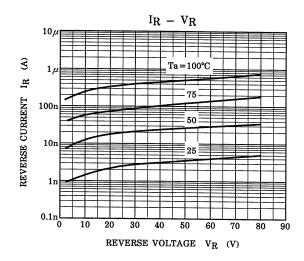


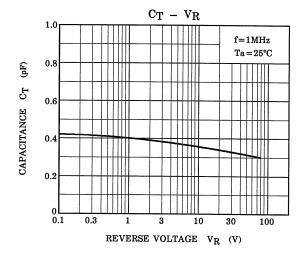




Q2

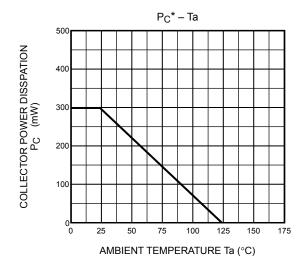






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Q1, Q2 Common



*Total Rating.

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